Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/788,571	SHIH ET AL.
Examiner	Art Unit
Edna Wong	1753

SEARCHED					
Class	Subclass	Date	Examiner		
205	238	12/6/2005	EW		
205	261	12/6/2005	EW		
	,				

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
261	11/20/2006	EW		
238	11/20/2006	EW		
	Subclass 261	Subclass Date 261 11/20/2006		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor Search	12/6/2005	EW	
EAST	12/6/2005	EW	
STN	12/6/2005	EW	
Search Updated	5/15/2006	EW	
Search Updated	11/19/2006	EW	